Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/802,669	LEE, WAI-HON	
Examiner	Art Unit	
Brian J. Livedalen	2878	

	SEARCHED		
Class	Subclass	Date	Examiner
250	237G	1/20/2006	BL
	<u>-</u>		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Database: East-USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	1/20/2006	BL		
Consulted Thanh Luu in class 250.	1/20/2006	BL		